

Determination of modulus of elasticity, nanohardness and residual stresses in brush-plated gold and silver coatings on copper substrate

Lille, Harri; Kõo, Jakub; Rjabtšikov, Aleksander; **Veinthal, Renno; Mikli, Valdek; Sergejev, Fjodor** Materials science =

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Interaction of point defects with impurities in the Si-SiO₂ system and its influence on the interface properties

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Investigation of residual stresses and some elastic properties of brush-plated gold and silver galvanic coatings

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Stress relaxation mechanism by strain in the Si-SiO₂ system and its influence on the interface properties

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Understanding and control of stress at Si-SiO₂ interface

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